

Search Notes

Application/Control No.

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Examiner

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Applicant(s)/Patent under
Reexamination

ONOZAWA ET AL.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
315	169.3, 169.4	11/9/2005	LA
345	55, 60	11/9/2005	LA
345	204	11/9/2005	LA
327	111, 333	11/9/2005	LA

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST prior art text search (see "Examiner Search Notes")	11/9/2005	LA